



# N-Channel 20 V (D-S) MOSFET

PRODUCT SUMMARY						
V <sub>DS</sub> (V)	R <sub>DS(on)</sub> (Ω) MAX.	I <sub>D</sub> (A)	Q <sub>g</sub> (TYP.)			
	0.033 at V <sub>GS</sub> = 4.5 V	16 <sup>e</sup>				
20	0.037 at V <sub>GS</sub> = 2.5 V	16 <sup>e</sup>	7.5 nC			
	0.042 at V <sub>GS</sub> = 1.8 V	15				

# MICRO FOOT® 1.5 x 1 S D S S S D Backside View Bump Side View

Marking Code: xxxx = 8406

xxx = Date / lot traceability code

## **Ordering Information:**

Si8406DB-T2-E1 (Lead (Pb)-free and halogen-free)

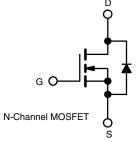
### **FEATURES**

- TrenchFET® power MOSFET
- Ultra-small 1.5 mm x 1 mm maximum outline
- Ultra-thin 0.59 mm maximum height
- Material categorization: for definitions of compliance please see <u>www.vishay.com/doc?99912</u>



### **APPLICATIONS**

- · Load switch
- · Battery management
- Boost converter



<b>ABSOLUTE MAXIMUM RATINGS</b>	$(T_A = 25  ^{\circ}C,  unless)$	otherwise noted	d)	
PARAMETER	SYMBOL	LIMIT	UNIT	
Drain-Source Voltage		V <sub>DS</sub>	20	V
Gate-Source Voltage		V <sub>GS</sub>	± 8	v
	T <sub>C</sub> = 25 °C		16 <sup>e</sup>	
Continuous Drain Current (T <sub>.I</sub> = 150 °C)	T <sub>C</sub> = 70 °C		13.5	
Continuous Drain Current (1) = 150 C)	T <sub>A</sub> = 25 °C	I <sub>D</sub>	7.8 <sup>a,b</sup>	
	T <sub>A</sub> = 70 °C		6.2 <sup>a,b</sup>	Α
Pulsed Drain Current (t = 300 μs)		I <sub>DM</sub>	30	
Continuous Source-Drain Diode Current	T <sub>C</sub> = 25 °C	1	11	
	T <sub>A</sub> = 25 °C	I <sub>S</sub>	2.3 <sup>a,b</sup>	
	T <sub>C</sub> = 25 °C		13	
Maying Dawar Dissination	T <sub>C</sub> = 70 °C	D	8.4	w
Maximum Power Dissipation	T <sub>A</sub> = 25 °C	P <sub>D</sub>	2.77 <sup>a,b</sup>	vv
	T <sub>A</sub> = 70 °C		1.77 <sup>a,b</sup>	
Operating Junction and Storage Temperature F	T <sub>J</sub> , T <sub>stg</sub>	-55 to +150	°C	
Package Reflow Conditions <sup>c</sup>	IR/Convection		260	

#### Notes

- a. Surface mounted on 1" x 1" FR4 board.
- b. t = 10 s.
- c. Refer to IPC/JEDEC® (J-STD-020), no manual or hand soldering.
- d. Case in defined as the top surface of the package.
- e. T<sub>C</sub> = 25 °C package limited.

S15-0932-Rev. B, 20-Apr-15

THERMAL RESISTANCE RATINGS							
PARAMETER	SYMBOL	TYPICAL	MAXIMUM	UNIT			
Maximum Junction-to-Ambient a,b	$R_{thJA}$	37	45	°C/W			
Maximum Junction-to-Case (Drain) <sup>c</sup>	Steady State	$R_{thJC}$	7	9.5	]		

## Notes

- a. Surface mounted on 1" x 1" FR4 board.
- b. Maximum under steady state conditions is 85 °C/W.
- c. Case is defined as top surface of the package.

1 Document Number: 62530

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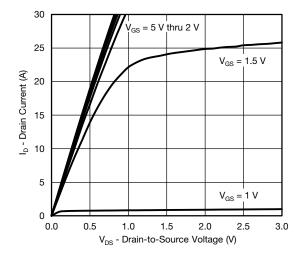
PARAMETER	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT
Static				1		
Drain-Source Breakdown Voltage	$V_{DS}$	$V_{GS} = 0$ , $I_D = 250 \mu A$	20	-	-	V
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_{J}$	L 050 A	-	18	-	
V <sub>GS(th)</sub> Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	I <sub>D</sub> = 250 μA	-	-3	-	mV/°C
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	$V_{DS} = V_{GS}, I_D = 250 \mu A$	0.4	-	0.85	V
Gate-Source Leakage	I <sub>GSS</sub>	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 8 \text{ V}$	-	-	± 100	nA
Zana Oata Valtana Busin Ouwant		V <sub>DS</sub> = 20 V, V <sub>GS</sub> = 0 V	-	-	1	μΑ
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> = 20 V, V <sub>GS</sub> = 0 V, T <sub>J</sub> = 70 °C	-	-	10	
On-State Drain Current <sup>a</sup>	I <sub>D(on)</sub>	$V_{DS} \ge 5 \text{ V}, V_{GS} = 4.5 \text{ V}$	5	-	-	Α
	,	V <sub>GS</sub> = 4.5 V, I <sub>D</sub> = 1 A	0.026	0.033		
Drain-Source On-State Resistance <sup>a</sup>	R <sub>DS(on)</sub>	V <sub>GS</sub> = 2.5 V, I <sub>D</sub> = 1 A	-	0.028	0.037	Ω
	DO(011)	V <sub>GS</sub> = 1.8 V, I <sub>D</sub> = 1 A - 0.030 0.				
Forward Transconductance a	9 <sub>fs</sub>	V <sub>DS</sub> = 10 V, I <sub>D</sub> = 1 A	-	20		S
Dynamic <sup>b</sup>						
Input Capacitance	C <sub>iss</sub>		-	830	-	pF
Output Capacitance	C <sub>oss</sub>	$V_{DS} = 10 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$	-	146	-	
Reverse Transfer Capacitance	C <sub>rss</sub>		-	61	-	
Total Gate Charge	Q <sub>g</sub>	V <sub>DS</sub> = 10 V, V <sub>GS</sub> = 8 V, I <sub>D</sub> = 1 A	-	13	20	
			-	7.5	12	nC
Gate-Source Charge		$V_{DS} = 10 \text{ V}, V_{GS} = 4.5 \text{ V}, I_D = 1 \text{ A}$	-	1.1	-	
Gate-Drain Charge	Q <sub>gd</sub>		-	0.8	-	
Gate Resistance	$R_g$	V <sub>GS</sub> = 0.1 V, f = 1 MHz	-	3.6	-	Ω
Turn-On Delay Time	t <sub>d(on)</sub>		-	7	15	
Rise Time	t <sub>r</sub>	$V_{DD} = 10 \text{ V}, R_1 = 10 \Omega$	-	18	40	ns
Turn-Off Delay Time	t <sub>d(off)</sub>	$I_D \cong 1$ Å, $V_{GEN} = 4.5$ V, $R_g = 1$ $\Omega$	-	30	60	
Fall Time	t <sub>f</sub>		-	10	20	
Turn-On Delay Time	t <sub>d(on)</sub>		-	5	10	ns
Rise Time	t <sub>r</sub>	$V_{DD} = 10 \text{ V}, R_1 = 10 \Omega$	-	17	35	
Turn-Off Delay Time	t <sub>d(off)</sub>	$I_D = 1 \text{ A}, V_{GEN} = 8 \text{ V}, R_g = 1 \Omega$	-	25	50	
Fall Time	t <sub>f</sub>		-	10	20	
Drain-Source Body Diode Characteri	stics					
Continuous Source-Drain Diode Current	Is	T <sub>C</sub> = 25 °C	-	-	20	Α
Pulse Diode Forward Current	I <sub>SM</sub>		-	-	30	
Body Diode Voltage	$V_{SD}$	I <sub>S</sub> = 1 A, V <sub>GS</sub> = 0	-	0.7	1.2	V
Body Diode Reverse Recovery Time	t <sub>rr</sub>		-	15	30	ns
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>		-	5	10	nC
Reverse Recovery Fall Time	ta	$I_F = 1 \text{ A, dl/dt} = 100 \text{ A/}\mu\text{s, T}_J = 25 ^{\circ}\text{C}$	-	8	-	ns
Reverse Recovery Rise Time	t <sub>b</sub>		-	7	-	

#### Notes

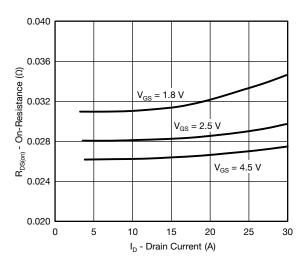
- a. Pulse test; pulse width  $\leq 300~\mu s,$  duty cycle  $\leq 2~\%.$
- b. Guaranteed by design, not subject to production testing.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

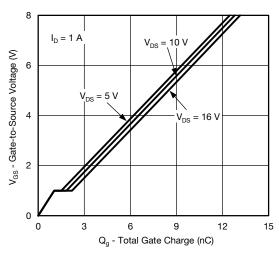




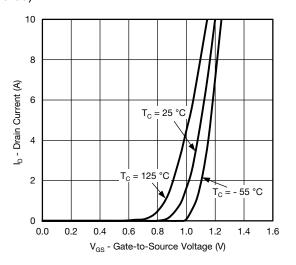
#### **Output Characteristics**



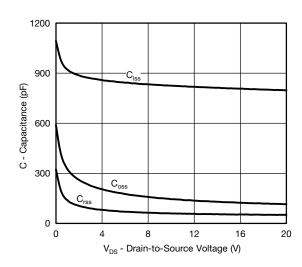
On-Resistance vs. Drain Current and Gate Voltage



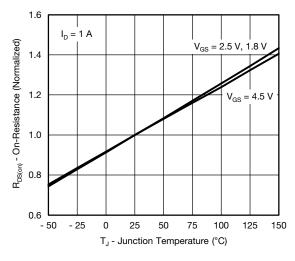
**Gate Charge** 



**Transfer Characteristics** 

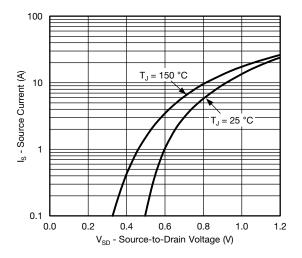


Capacitance

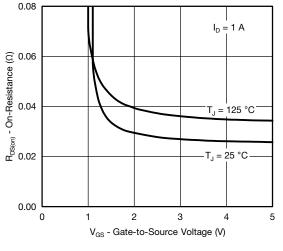


On-Resistance vs. Junction Temperature

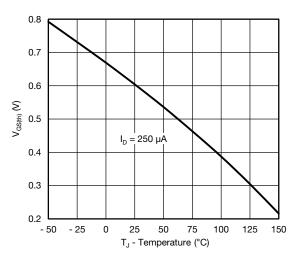




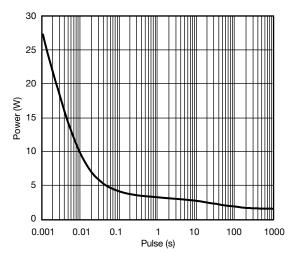
#### Source-Drain Diode Forward Voltage



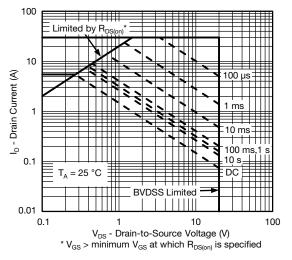
On-Resistance vs. Gate-to-Source Voltage



**Threshold Voltage** 

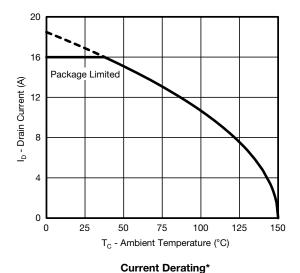


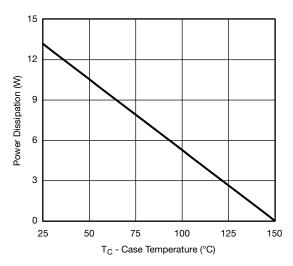
Single Pulse Power, Junction-to-Ambient



Safe Operating Area, Junction-to-Ambient



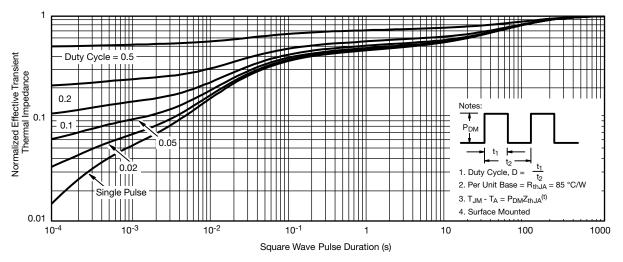




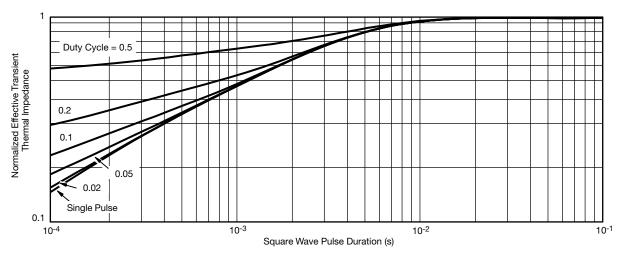
**Power Derating** 

<sup>\*</sup> The power dissipation P<sub>D</sub> is based on T<sub>J (max.)</sub> = 150 °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.





Normalized Thermal Transient Impedance, Junction-to-Ambient



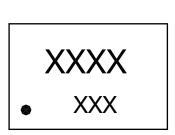
Normalized Thermal Transient Impedance, Junction-to-Case

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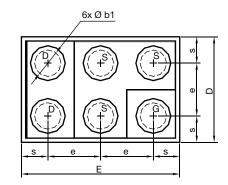
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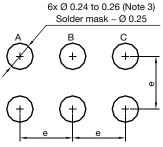
# MICRO FOOT®: 6-Bump (1.5 mm x 1 mm, 0.5 mm Pitch, 0.250 mm Bump Height)

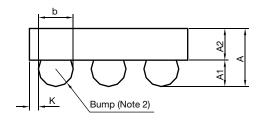


Mark on Backside of Die









Recommended Land Pattern

#### **Notes**

(unless otherwise specified)

- 1. Six (6) solder bumps are 95.5/3.8/0.7 Sn/Ag/Cu.
- 2. Backside surface is coated with a Ti/Ni/Ag layer.
- 3. Non-solder mask defined copper landing pad.
- 4. Laser marks on the silicon die back.
- 5. "b1" is the diameter of the solderable substrate surface, defined by an opening in the solder resist layer solder mask defined.
- 6. is the location of pin 1

DIM.	MILLIMETERS			INCHES				
	MIN.	NOM.	MAX.	MIN.	NOM.	MAX.		
Α	0.510	0.575	0.590	0.0201	0.0226	0.0232		
A <sub>1</sub>	0.220	0.250	0.280	0.0087	0.0098	0.0110		
A <sub>2</sub>	0.290	0.300	0.310	0.0114	0.0118	0.0122		
b	0.297	0.330	0.363	0.0116	0.0129	0.0143		
b1		0.250			0.0098			
е	0.500			0.0197				
s	0.210	0.230	0.250	0.0082	0.0090	0.0098		
D	0.920	0.960	1.000	0.0362	0.0378	0.0394		
E	1.420	1.460	1.500	0.0559	0.0575	0.0591		
K	0.028	0.065	0.102	0.0011	0.0025	0.0040		

#### Note

Use millimeters as the primary measurement.

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Revison: 20-Apr-15 Document Number: 69426

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